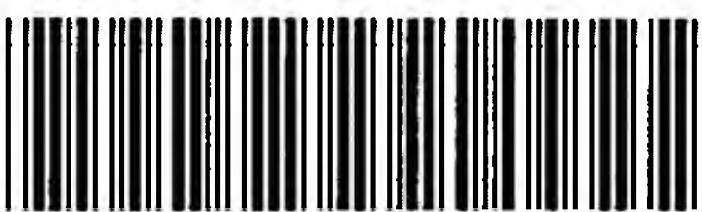


## **Search Notes**



**Application/Control No.**

10/711 527

## **Examiner**

Tianjie Chen

**Applicant(s)/Patent under  
Reexamination**

THORNTON ET AL

## **Art Unit**

2627

**SEARCHED**

# SEARCHED

Class	Subclass	Date	Examiner
369	300		
	44.12		
	44.23		
	112		
	116		
	121		
	112.23		
	13.23		
	275.4		
427	586		
720	659	2/16/2007	TJ

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner